

## SSC8329GS1

#### **Dual P-Channel Enhancement Mode MOSFET**

#### Features

V <sub>DS</sub>	$V_{GS}$	R <sub>DS(ON)</sub> Typ.	l <sub>D</sub>
-20V	±12V	13mΩ@-4V5	-13A
		16mΩ@-2V5	-137

#### > Description

This device is produced with high cell density, DMOS trench technology, which is especially used to minimize on-state resistance. This device is particularly suited for low voltage power management requiring a wild range of given voltage ratings(4.5V~25V) such as load switch and battery protection.

#### Applications

- NB Battery
- DC/DC Conversion
- Load Switch

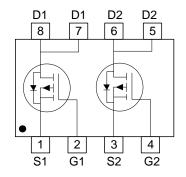
#### Ordering Information

Device	Package	Shipping
SSC8329GS1	SOP-8	4000/Reel

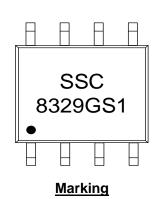
#### Pin configuration



SOP-8 (Top View)



**Pin Configuration** 





### ➤ Absolute Maximum Ratings (T<sub>A</sub>=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit	
$V_{DSS}$	Drain-to-Source Voltage	-20	V	
$V_{GSS}$	Gate-to-Source Voltage	±12	V	
I <sub>D</sub>	Continuous Drain Current a	-13	Α	
I <sub>DM</sub>	Pulsed Drain Current <sup>b</sup>	-51	А	
P <sub>D</sub>	Power Dissipation <sup>c</sup>	5.4	W	
P <sub>DSM</sub>	Power Dissipation <sup>a</sup>	2.2	W	
TJ	Operation junction temperature	-55~150	°C	
T <sub>STG</sub>	Storage temperature range	-55~150		

#### ➤ Thermal Resistance Ratings (T<sub>A</sub>=25°C unless otherwise noted)

Symbol	Parameter	Maximum	Unit	
RθJA	Junction-to-Ambient Thermal Resistance a	60	°C/W	
$R_{ heta JC}$	Junction-to-Case Thermal Resistance	Junction-to-Case Thermal Resistance 25		

#### Note:

- a. The value of R<sub>θJA</sub> is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz.copper, in a still air environment with T<sub>A</sub>=25 °C. The value in any given application depends on the user is specific board design. The power dissipation is based on the t≤10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.

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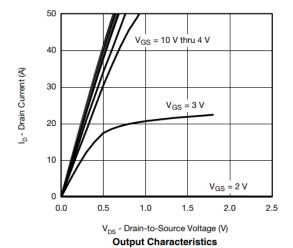


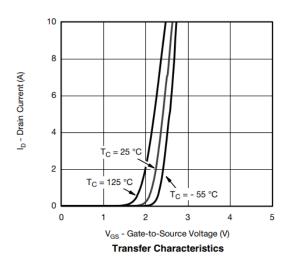
# > Electrical Characteristics (T<sub>A</sub>=25℃ unless otherwise noted)

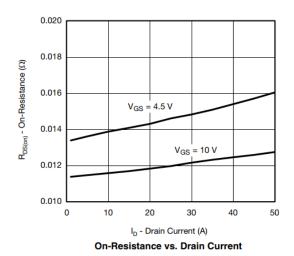
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = -250μA	-20			V
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250uA$	-0.5		-1.5	V
B 1 0 0 5 11	R <sub>DS(on)</sub>	V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -10A		13	18	- mΩ
Drain-Source On-Resistance		V <sub>GS</sub> = -2.5V, I <sub>D</sub> = -7A		16	22	
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = -16V, V <sub>GS</sub> = 0V			-1	μA
Gate-Source Leak Current	Igss	$V_{GS} = \pm 12V, V_{DS} = 0V$			±100	nA
Transconductance	G <sub>FS</sub>	$V_{DS} = -10V, I_{D} = -3.6A$		16		s
Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0V, I <sub>S</sub> = -2.3A			-1.3	V
Input Capacitance	Ciss	\/ 45\/\\ 0\/		1020		
Output Capacitance	Coss	$V_{DS} = -15V$ , $V_{GS} = 0V$ , $f = 1MHz$		110		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>	T = TIVIDZ		90		
Total Gate Charge	Q <sub>G</sub>	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \		13		
Gate to Source Charge	Q <sub>GS</sub>	$V_{GS} = -4.5V$ , $V_{DS} = -15V$ , $I_{D} = -3A$		3.3		nC
Gate to Drain Charge	$Q_{GD}$	ID = -3A		4.4		
Turn-on Delay Time	T <sub>D(ON)</sub>			11		
Rise Time	Tr	V <sub>GS</sub> = -10V, V <sub>DS</sub> = -15V,		10		
Turn-off Delay Time	T <sub>D(OFF)</sub>	$R_L = 1.5\Omega, R_G = 3\Omega$		51		ns
Fall Time	Tf			29		

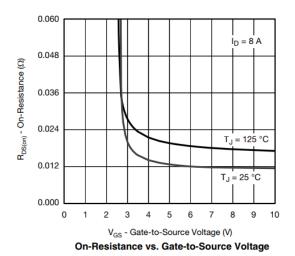


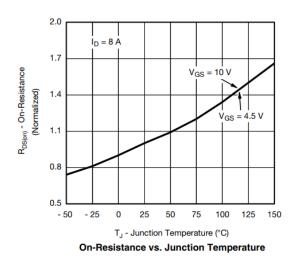
## > Typical Performance Characteristics (T<sub>A</sub>=25℃ unless otherwise noted)

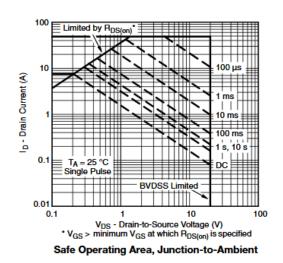




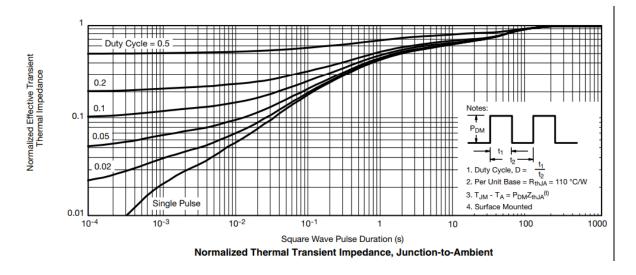




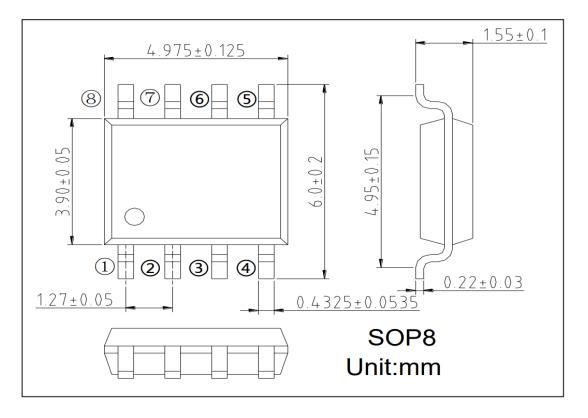








## Package Information





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